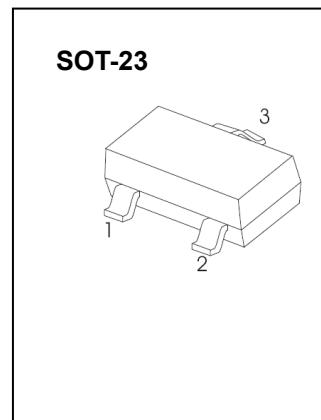


**FEATURES**

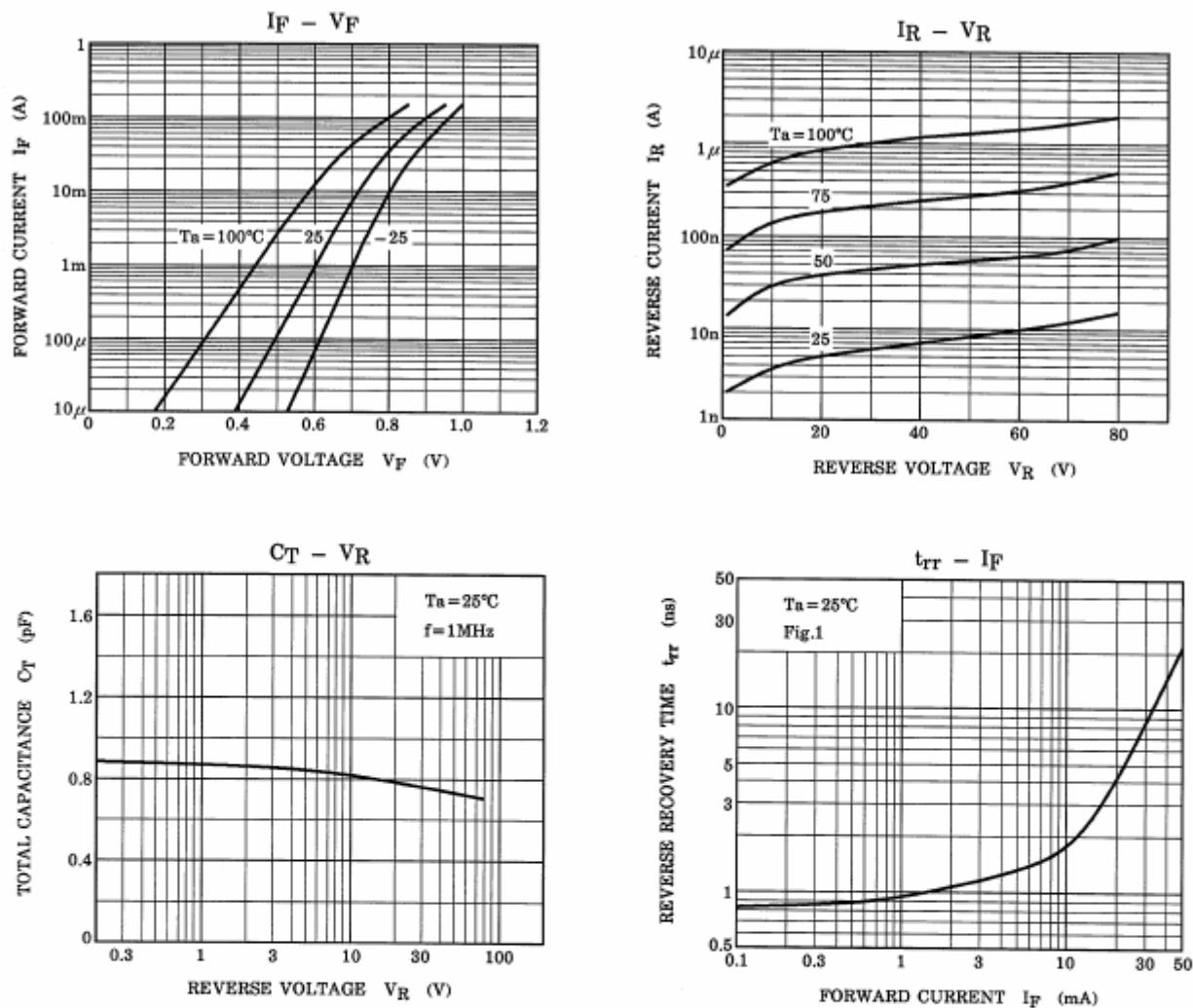
- Low forward voltage :  $V_F$  (3) = 0.9V (typ.)
- Fast reverse recovery time :  $t_{rr}$  = 1.6ns (typ.)
- Small total capacitance :  $C_T$  = 0.9pF (typ.)

**MARKING: C3****Maximum Ratings ,Single Diode @ $T_A=25^\circ\text{C}$** 

Parameter	Symbol	Limits	Unit
Non-Repetitive Peak reverse voltage	$V_{RM}$	85	V
Peak Repetitive Peak reverse voltage	$V_{RRM}$		
Working Peak Reverse Voltage	$V_{RWM}$	80	V
DC Blocking Voltage	$V_R$		
Forward Continuous Current	$I_{FM}$	300	mA
Average Rectified Output Current	$I_O$	100	mA
Peak forward surge current @=10ms	$I_{FSM}$	2	A
Power Dissipation	$P_D$	150	mW
Junction temperature	$T_J$	150	°C
Storage temperature	$T_{STG}$	-55-150	°C

**ELECTRICAL CHARACTERISTICS (Tamb=25°C unless otherwise specified)**

Parameter	Symbol	Test conditions	MIN	MAX	UNIT
Reverse breakdown voltage	$V_{(BR)}$	$I_R= 100\mu\text{A}$	80		V
Reverse voltage leakage current	$I_R$	$V_R=80\text{V}$		0.5	uA
Forward voltage	$V_F$	$I_F=100\text{mA}$		1.2	V
Diode capacitance	$C_D$	$V_R=0\text{V}$ , $f=1\text{MHz}$		3	pF
Reverse recovery time	$t_{rr}$	$I_F=10\text{mA}$		4	nS



**Fig.1 Reverse recovery time ( $t_{rr}$ ) test circuit**

